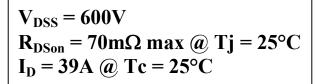
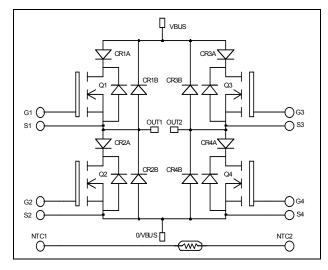


Full – Bridge Series & SiC parallel diodes Super Junction MOSFET Power Module





G4 🛭

S4 🛭

S2 #

G2 fl

O/VBUS

OUT2

OUTI

NTC2 0 NTC1 0

Application

- Motor control
- Switched Mode Power Supplies
- Uninterruptible Power Supplies

Features

• CoolMOSTM

- Ultra low R_{DSon}
- Low Miller capacitance
- Ultra low gate charge
- Avalanche energy rated

• Parallel SiC Schottky Diode

- Zero reverse recovery
- Zero forward recovery
- Temperature Independent switching behavior
- Positive temperature coefficient on VF
- Kelvin source for easy drive
- Very low stray inductance
- Lead frames for power connections
- Internal thermistor for temperature monitoring
- High level of integration

Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- RoHS compliant

All ratings @ $T_j = 25$ °C unless otherwise specified

Absolute maximum ratings

0 G3

8 S3

VBUS

Symbol	Parameter		Max ratings	Unit
$ m V_{DSS}$	Drain - Source Voltage		600	V
I_D		$T_c = 25^{\circ}C$	39	
	Continuous Drain Current	$T_c = 80$ °C	29	A
I_{DM}	Pulsed Drain current		160	
V_{GS}	Gate - Source Voltage		±20	V
R_{DSon}	Drain - Source ON Resistance		70	mΩ
P_{D}	Maximum Power Dissipation	$T_c = 25$ °C	250	W
I_{AR}	Avalanche current (repetitive and non repetitive)		20	A
E_{AR}	Repetitive Avalanche Energy		1	I
E_{AS}	Single Pulse Avalanche Energy		1800	mJ

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com



Electrical Characteristics

	Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
I_{DSS}	Zero Gate Voltage Drain Current	$V_{GS} = 0V, V_{DS} = 600V$ $T_j = 25^{\circ}C$			25	A	
		$V_{GS} = 0V, V_{DS} = 600V$ $T_j = 125^{\circ}C$	C		250	μΑ	
ſ	R _{DS(on)}	Drain – Source on Resistance	$V_{GS} = 10V, I_D = 39A$			70	mΩ
	$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 2.7 \text{mA}$		3	3.9	V
	I_{GSS}	Gate – Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±100	nA

Dynamic Characteristics

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
C_{iss}	Input Capacitance	$V_{GS} = 0V$		7		
C_{oss}	Output Capacitance	$V_{\rm DS} = 25V$		2.56		nF
C_{rss}	Reverse Transfer Capacitance	f = 1MHz		0.21		
Q_{g}	Total gate Charge	$V_{GS} = 10V$		259		
Q_{gs}	Gate – Source Charge	$V_{\text{Bus}} = 300 \text{V}$		29		nC
Q_{gd}	Gate – Drain Charge	$I_D = 39A$		111		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching @ 125°C $V_{GS} = 15V$ $V_{Bus} = 400V$ $I_D = 39A$		21		
$T_{\rm r}$	Rise Time			30		ns
$T_{d(off)}$	Turn-off Delay Time			283		
T_{f}	Fall Time	$R_G = 5\Omega$		84		
Eon	Turn-on Switching Energy	Inductive switching @ 25°C		402		T
E_{off}	Turn-off Switching Energy	$V_{GS} = 15V, V_{Bus} = 400V$ $I_D = 39A, R_G = 5\Omega$		980		μJ
Eon	Turn-on Switching Energy	Inductive switching @ 125°C $V_{GS} = 15V$, $V_{Bus} = 400V$ $I_D = 39A$, $R_G = 5\Omega$		658		T
E_{off}	Turn-off Switching Energy			1206		μJ
R_{thJC}	Junction to Case Thermal Resistance				0.5	°C/W

Series diode ratings and characteristics

Symbol	Characteristic Test Conditions		Min	Тур	Max	Unit	
V_{RRM}	Peak Repetitive Reverse Voltage					600	V
I_{RM}	Reverse Leakage Current	$V_{R} = 600V$				50	μA
I_F	DC Forward current		$Tc = 80^{\circ}C$		50		A
$V_{\rm F}$	Diode Forward Voltage	$I_F = 50A$ $V_{GE} = 0V$	$T_i = 25^{\circ}C$ $T_i = 150^{\circ}C$		1.6	2	V
t	t _{rr} Reverse Recovery Time	$T_j = 25$ °C		100		ns	
t_{rr}	Reverse Recovery Time		$T_{j} = 150^{\circ}C$		150		115
Q_{rr}	Reverse Recovery Charge	$I_F = 50A$ $V_R = 300V$ $di/dt = 1800A/\mu s$	$T_j = 25$ °C		2.6		μС
Qrr	Reverse Recovery Charge		$T_j = 150$ °C		5.4	<u> </u>	μС
E_{rr}	Reverse Recovery Energy	1	$T_i = 25^{\circ}C$		0.60		mJ
∟rr	Reverse Recovery Energy		$T_j = 150$ °C		1.2		1113
R_{thJC}	Junction to Case Thermal Resistance	·				1.42	°C/W



Parallel diode ratings and characteristics

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
V_{RRM}	Maximum Peak Repetitive Reverse Volta	ge		600			V
I_{RM}	Maximum Reverse Leakage Current	$V_R = 600V$ $T_j = 25^{\circ}C$ $T_j = 175^{\circ}C$			100 200	400 2000	μА
I_F	DC Forward Current	$Tc = 125^{\circ}C$			20		Α
V_{F}	Diode Forward Voltage	$I_F = 20A$ $T_i = 25^{\circ}C$ $T_i = 175^{\circ}C$			1.6 2.0	1.8	V
Q_{C}	Total Capacitive Charge	$I_F = 20A, V_R = 600V$ di/dt =800A/ μ s			56		nC
C	TALC	$f = 1 MHz, V_R =$	= 200V		130		E
	Total Capacitance $f = 1MHz$		= 400V		100		pF
R_{thJC}	Junction to Case Thermal Resistance					1.5	°C/W

Thermal and package characteristics

Symbol	Characteristic			Min	Max	Unit
V_{ISOL}	RMS Isolation Voltage, any terminal to ca	S Isolation Voltage, any terminal to case t = 1 min, 50/60Hz				V
T_{J}	Operating junction temperature range			-40	150	
T_{JOP}	Recommended junction temperature under switching conditions			-40	T _J max -25	°C
T_{STG}	Storage Temperature Range			-40	125	C
$T_{\rm C}$	Operating Case Temperature			-40	100	
Torque	Mounting torque	To Heatsink	M5	2.5	4.7	N.m
Wt	Package Weight				160	g

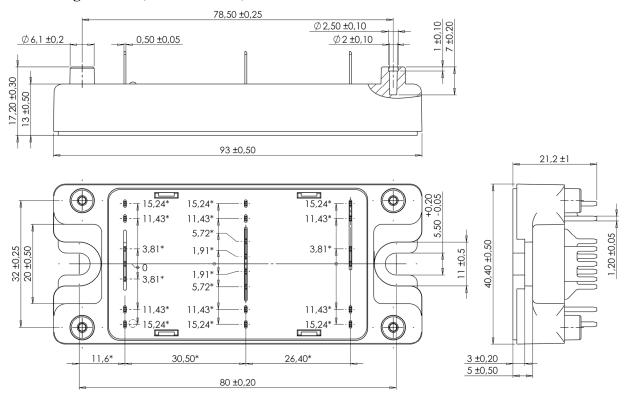
Temperature sensor NTC (see application note APT0406 on www.microsemi.com).

Symbol	Characteristic	,	Min	Тур	Max	Unit
R ₂₅	Resistance @ 25°C			50		kΩ
$\Delta R_{25}/R_{25}$				5		%
${ m B}_{25/85}$	$T_{25} = 298.15 \text{ K}$			3952		K
$\Delta B/B$		Γ _C =100°C		4	·	%

$$R_{T} = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$$
 T: Thermistor temperature R_T: Thermistor value at T



SP4 Package outline (dimensions in mm)

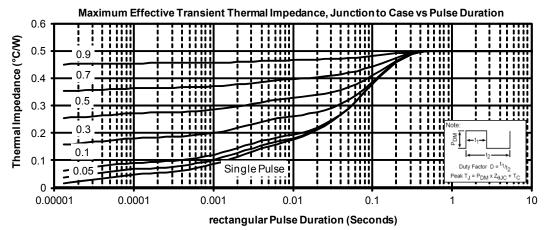


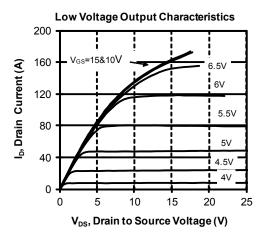
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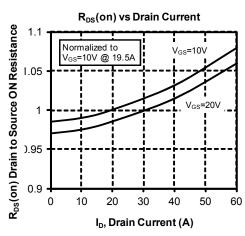
See application note APT0501 - Mounting Instructions for SP4 Power Modules on www.microsemi.com

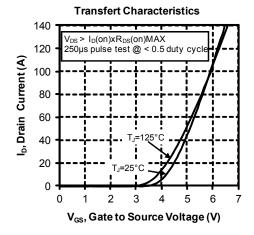


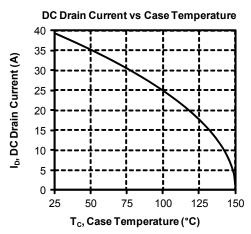
Typical CoolMOS Performance Curve



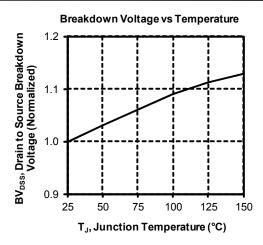


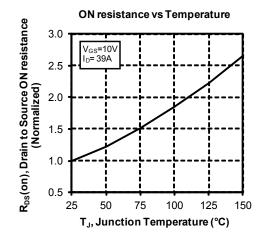


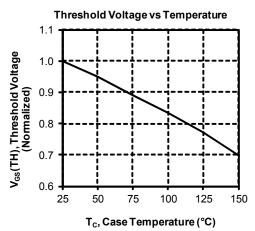


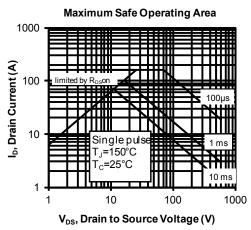


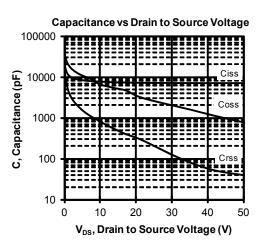


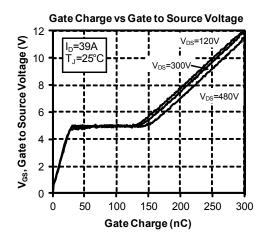




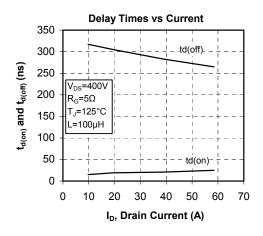


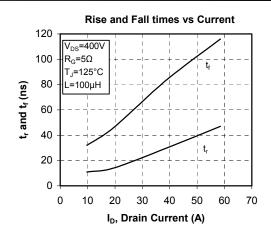


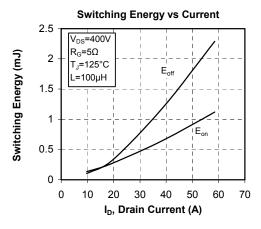


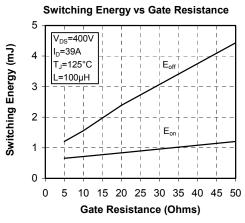


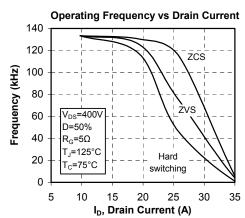


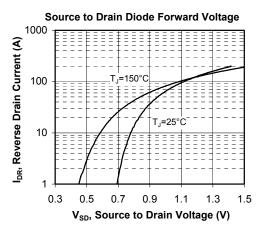






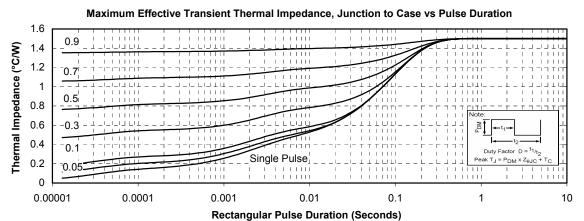


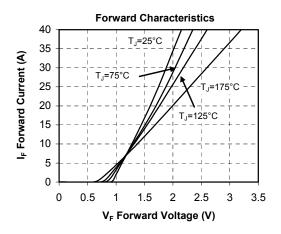


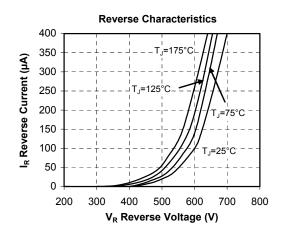


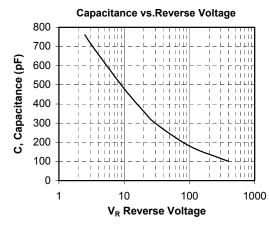


Typical SiC Diode Performance Curve









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